

Search Notes

Application/Control No.

10/529,165

Examiner

JOHN J. LEE

Applicant(s)/Patent under
Reexamination

MATSUI ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	3.01,3.04 3.02,3.06 525,517 502	1/13/2009	J.L
455	550.1,524	1/13/2009	J.L
455	67.11,503	1/13/2009	J.L
455	428,82	1/13/2009	J.L

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
455	3.04,525	1/17/2009	J.L
455	3.01,517	1/17/2009	J.L
455	3.02,428	1/17/2009	J.L
Interference and Inventor search		1/17/2009	J.L

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	1/13/2009	J.L